High-power distributed Bragg reflector lasers operating at 1065 nm

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A report is presented on distributed Bragg reflector lasers emitting in excess of 700 mW in a single-spatial and single-spectral mode at 1065 nm. The threshold current of these devices is ~30 mA, there is an L-I slope of 0.74 W/A, and a sidemode suppression ratio greater than 30 dB. The current and thermal tuning are 0.016 Å/mA and 0.7 Å/°C, respectively.

Introduction: High-power single-frequency laser diodes emitting around 1065 nm are of interest for a variety of applications including direct replacement of Nd:YAG lasers, spectroscopy, gas-sensing or THz generation [1–4]. These first-order distributed Bragg reflector (DBR) ridge waveguide lasers, fabricated with holographic lithography and without regrowth, are expected to have high reliability and low cost in high volume production.

Fabrication: The DBR lasers were processed from an MBE grown structure consisting of an n-cladding layer, an InGaAs single quantum well (SQW), which is centred in a 300 nm-thick AlGaAs graded region, a p-cladding layer and a highly-doped GaAs cap layer. A detailed structure and basic processing steps for such ridge-type lasers have been published in [5]. The DBR lasers consist of a 400 μm-long DBR section that provides selective feedback using a first-order grating fabricated by holographic lithography with a grating period of $\lambda_B = 1608$ Å. The grating coupling coefficient is 50 cm$^{-1}$ and is controlled by the etch depth. The gain section has a length of 2000 μm and the width of the ridge is ~3 μm. The optical cavity is formed by the rear DBR mirror and a cleaved and coated front facet.

Following device fabrication, the wafers are thinned to approximately 100 μm and metallised. After bar-cleaving and passivation of the front and rear facet an antireflection coating of around 5% is applied to the front facet. Single devices are separated using conventional dicing techniques and are mounted junction-side down on c-mounts. All measurements are made under continuous-wave (CW) conditions and at room temperature.

Results: Fig. 1 shows optical power from the front facet and voltage against injection current for a typical DBR device. The device has a threshold current of 30 mA and the slope of the L-I curve above threshold is 0.74 W/A. At a maximum applied injection current of 1.0 A the emitted power exceeds 700 mW. The series resistance $R_s = 1.0$ Ω. Although the devices emit in a single spatial and spectral mode, the L-I curve shows several discontinuities, with the distance between the discontinuities decreasing with increasing current. These discontinuities are associated with small wavelength jumps of 0.63 Å, which correspond to the value for the longitudinal mode spacing (see inset of Fig. 1).

In general, the mode closest to the DBR peak reflectivity has the lowest modal loss and hence becomes the lasing mode. As the injection current and therefore the temperature increases, the modes shift to longer wavelengths, but at a faster rate than the reflectivity spectrum. As the lasing mode moves away from the DBR peak reflectivity, there comes a point where the adjacent mode has a higher reflectivity. At this point the wavelength suddenly jumps to a new mode, resulting in a 0.63 Å decrease in the emission wavelength. Between these mode jumps, the wavelength can be tuned continuously. The inset of Fig. 1 shows the possible different stable modes [6], indicated as solid circles. For this specific example, the DBR has a cleaved end facet (semiconductor–air interface) located at half the grating period. Other DBR cleave locations will be treated below.

The optical spectrum for different power levels is shown in Fig. 2. The full-width at half maximum (FWHM) value of the oscillating mode is limited by the resolution of the optical spectrum analyser (0.2 Å). The wavelength tuning rate with current is 0.016 Å/mA and with temperature is 0.7 Å/°C measured between 100 and 500 mW. The laser emits in a single spatial and spectral mode with a sidemode suppression ratio exceeding 40 dB for power levels below 550 mW. For
power levels above 550 mW the sidemode suppression ratio decreases to about 30 dB at 600 mW.

**Fig. 4** Calculated distribution of effective DBR reflectivity

*Conclusions:* Singlemode, single-frequency DBR lasers have been fabricated with power levels exceeding 700 mW. The emission spectrum of the DBR device tunes quasi-continuously with tuning coefficients of 0.016 A/°C and 0.7 A/°C. The sidemode suppression ratio is greater than 30 dB over the entire range of operation. Theoretical investigation of the effect of random cleaving positions within the DBR showed that the mean value of the effective DBR reflectivity is increased by 1.7% compared with no end reflector.

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**References**